

LMX2492/LMX2492-Q1 14 GHz Low Noise Fractional N PLL with Ramp/Chirp Generation

1 Features

- -227 dBc/Hz Normalized PLL Noise
- 500 MHz - 14 GHz Wideband PLL
- 3.15 - 5.25 V Charge Pump PLL Supply
- Versatile Ramp / Chirp Generation
- 200 MHz Max Phase Detector Frequency
- FSK / PSK Modulation Pin
- Digital Lock Detect
- Single 3.3 V Supply Capability
- Automotive 125°C Q100 Grade 1 Qualification
- Non-Automotive (LMX2492) Option

2 Applications

- Automotive FMCW Radar
- Military Radar
- Microwave Backhaul
- Test and Measurement
- Satellite Communications
- Wireless Infrastructure
- Sampling Clock for High Speed ADC/DAC

3 Description

The LMX2492/92-Q1 is a low noise 14 GHz wideband delta-sigma fractional N PLL with ramp and chirp generation. It consists of a phase frequency detector, programmable charge pump, and high frequency input for the external VCO. The LMX2492/92-Q1 supports a broad and flexible class of ramping capabilities, including FSK, PSK, and configurable piecewise linear FM modulation profiles of up to 8 segments. It supports fine PLL resolution and fast ramp with up to a 200 MHz phase detector rate. The LMX2492/92-Q1 allows any of its registers to be read back. The LMX2492/92-Q1 can operate with a single 3.3 V supply. Moreover, supporting up to 5.25 V charge pump can eliminate the need of external amplifier, leading to a simpler solution with improved phase noise performance.

Device Information

PART NUMBER	PACKAGE	BODY SIZE (NOM)
LMX2492-Q1RTW	WQFN (24)	4.00 mm x 4.00 mm
LMX2492RTW	WQFN (24)	4.00 mm x 4.00 mm

(1) For all available packages, see the orderable addendum at the end of the datasheet.

4 Simplified Schematic

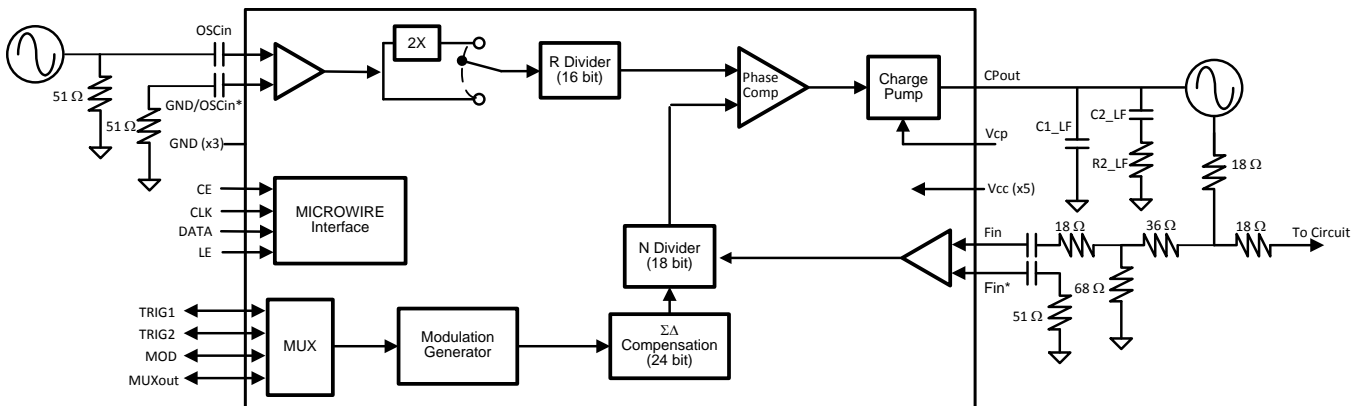


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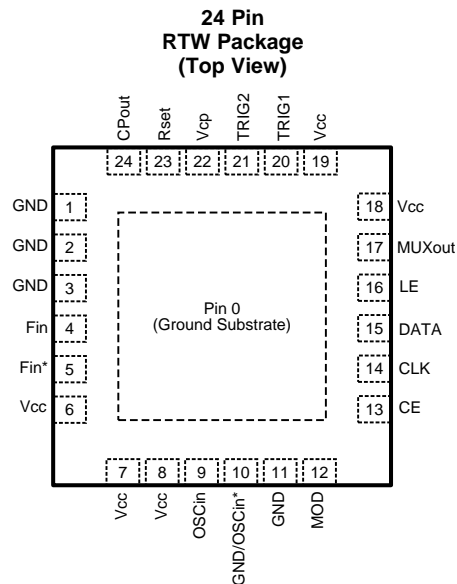
5 Revision History

Changes from Original (March 2014) to Revision A

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•	Changed from 35 to 10.....	6
•	Changed from 10 to 4.....	6
•	Changed from 10 to 4.....	6
•	Changed from 25 to 10	6
•	Changed from 25 to 10.....	6

6 Pin Configuration and Functions



Pin Functions

TERMINAL		TYPE	DESCRIPTION
NUMBER	NAME		
0	DAP	GND	Die Attach Pad. Connect to PCB ground plane.
1	GND	GND	Ground for charge pump.
2,3	GND	GND	Ground for Fin Buffer
4,5	Fin Fin*	Input	Complimentary high frequency input pins. Should be AC coupled. If driving single-ended, impedance as seen from Fin and Fin* pins looking outwards from the part should be roughly the same.
6	Vcc	Supply	Power Supply for Fin Buffer
7	Vcc	Supply	Supply for On-chip LDOs
8	Vcc	Supply	Supply for OSCin Buffer
9	OSCin	Input	Reference Frequency Input
10	GND/ OSCin*	GND/Input	Complimentary input for OSCin. If not used, it is recommended to match the termination as seen from the OSCin terminal looking outwards. However, this may also be grounded as well.
11	GND	GND	Ground for OSCin Buffer
12	MOD	Input/Output	Multiplexed Input/Output Pins for Ramp Triggers, FSK/PSK Modulation, FastLock, and Diagnostics
13	CE	Input	Chip Enable
14	CLK	GND	Serial Programming Clock.
15	DATA	GND	Serial Programming Data
16	LE	Input	Serial Programming Latch Enable
17	MUXout	Input/Output	Multiplexed Input/Output Pins for Ramp Triggers, FSK/PSK Modulation, FastLock, and Diagnostics
18	Vcc	Supply	Supply for delta sigma engine.
19	Vcc	Supply	Supply for general circuitry.
20	TRIG1	Input/Output	Multiplexed Input/Output Pins for Ramp Triggers, FSK/PSK Modulation, FastLock, and Diagnostics
21	TRIG2	Input/Output	Multiplexed Input/Output Pins for Ramp Triggers, FSK/PSK Modulation, FastLock, and Diagnostics
22	Vcp	Supply	Power Supply for the charge pump.
23	Rset	NC	No connect.
24	CPout	Output	Charge Pump Output

7 Specifications

7.1 Absolute Maximum Ratings

over operating free-air temperature range (unless otherwise noted) ⁽¹⁾

		MIN	MAX	UNIT
V _c p	Supply Voltage for Charge Pump	V _{cc}	5.5	V
CP _{out}	Charge Pump Output Pin	-0.3	V _c p	V
V _{cc}	All V _{cc} Pins	-0.3	3.6	V
Others	All Other I/O Pins	-0.3	V _{cc} + 0.3	V
T _{Solder}	Lead Temperature (solder 4 seconds)		260	°C
T _{Junction}	Junction Temperature		150	°C

- (1) Stresses beyond those listed under *Absolute Maximum Ratings* may cause permanent damage to the device. These are stress ratings only, which do not imply functional operation of the device at these or any other conditions beyond those indicated under *Recommended Operating Conditions*. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

7.2 Handling Ratings

		MIN	MAX	UNIT
T _{STG}	Storage Temperature Range	-65	150	°C
MSL	Moisture Sensitivity Level		3	n/a
V _{ESD} ⁽¹⁾	Human body model (HBM) ESD stress voltage ⁽²⁾		2500	V
	Charged device model (CDM) ESD stress voltage ⁽³⁾		1500	V

- (1) Electrostatic discharge (ESD) to measure device sensitivity and immunity to damage caused by assembly line electrostatic discharges in to the device.
 (2) Level listed above is the passing level per ANSI, ESDA, and JEDEC JS-001. JEDEC document JEP155 states that 500 V HBM allows safe manufacturing with a standard ESD control process.
 (3) Level listed above is the passing level per EIA-JEDEC JESD22-C101. JEDEC document JEP157 states that 250 V CDM allows safe manufacturing with a standard ESD control process.

7.3 Recommended Operating Conditions

over operating free-air temperature range (unless otherwise noted)

SYMBOL	PARAMETER	DEVICE	MIN	TYP	MAX	UNIT
V _{cc}	PLL Supply Voltage		3.15	3.3	3.45	V
V _c p	Charge Pump Supply Voltage		V _{cc}		5.25	V
T _A	Ambient Temperature	LMX2492	-40		85	°C
		LMX2492-Q1	-40		125	
T _J	Junction Temperature	LMX2492	-40		125	°C
		LMX2492-Q1	-40		135	

7.4 Thermal Information

	THERMAL METRIC ⁽¹⁾	Temperature	UNIT
R _{θJA}	Junction-to-ambient thermal resistance	39.4	°C/W
R _{θJC}	Junction-to-case thermal resistance	7.1	
ψ _{JB}	Junction-to-board characterization parameter	20	

- (1) For more information about traditional and new thermal metrics, see the *IC Package Thermal Metrics* application report, [SPRA953](http://www.ti.com/lit/zip/Spra953).

7.5 Electrical Characteristics

(3.15 V ≤ V_{CC} ≤ 3.45 V. V_{CC} ≤ V_{CP} ≤ 5.25 V. Typical values are at V_{CC} = V_{CP} = 3.3 V, 25 °C.

-40°C ≤ T_A ≤ 85 °C for the LMX2492 and -40°C ≤ T_A ≤ 125 °C for the LMX2492-Q1 ; except as specified.)

SYMBOL	PARAMETER	CONDITIONS	MIN	TYP	MAX	UNIT
I _{CC}	Current Consumption	All V _{CC} Pins	F _{PD} = 10 MHz	45		mA
			F _{PD} = 100 MHz	50		
			F _{PD} = 200 MHz	55		
		V _{CP} Pin	K _{PD} = 0.1 mA	2		
			K _{PD} = 1.6 mA	10		
			K _{PD} = 3.1 mA	19		
I _{CCPD}	Current	POWERDOWN		3		
f _{OSCin}	Frequency for OSCin terminal	OSC_DIFFR=0, Doubler Disabled	10		600	MHz
		OSC_DIFFR=0, Doubler Enabled	10		300	
		OSC_DIFFR=1, Doubler Disabled	10		1200	
		OSC_DIFFR=1, Doubler Enabled	10		600	
V _{OSCin}	Voltage for OSCin Pin ⁽¹⁾		0.5		V _{CC} -0.5	V _{pp}
f _{Fin}	Frequency for FinPin ⁽²⁾		500		14000	MHz
P _{Fin}	Power for Fin Pin	Single-Ended Operation	-5		5	dBm
f _{PD}	Phase Detector Frequency				200	MHz
PN1Hz	PLL Figure of Merit ⁽³⁾			-227		dBc/Hz
PN10kHz	Normalized PLL 1/f Noise ⁽³⁾	Normalized to 10 kHz offset for a 1 GHz carrier.		-120		dBc/Hz
I _{CPoutTRI}	Charge Pump Leakage Tri-state Leakage				10	nA
I _{CPoutMM}	Charge Pump Mismatch ⁽⁴⁾	V _{CPout} = V _{CP} / 2		5 %		
I _{CPout}	Charge Pump Current	V _{CPout} = V _{CP} / 2	CPG=1X	0.1		mA
			...			
			CPG=31X	3.1		

(1) For optimal phase noise performance, higher input voltage and a slew rate of at least 3 V/ns is recommended

(2) Tested to 13.5 GHz, Guaranteed to 14 GHz by characterization

(3) PLL Noise Metrics are measured with a clean OSCin signal with a high slew rate using a wide loop bandwidth. The noise metrics model the PLL noise for an infinite loop bandwidth as:

$$PLL_Total = 10 \times \log(10^{PLL_Flat/10} + 10^{PLL_Flicker(Offset)/10})$$

$$PLL_Flat = PN1Hz + 20 \times \log(N) + 10 \times \log(F_{pd}/1Hz)$$

$$PLL_Flicker = PN10kHz - 10 \times \log(Offset/10kHz) + 20 \times \log(F_{vco}/1GHz)$$

(4) Charge pump mismatch varies as a function of charge pump voltage. Consult typical performance characteristics to see this variation.

Electrical Characteristics (continued)

(3.15 V ≤ V_{CC} ≤ 3.45 V. V_{CC} ≤ V_{CP} ≤ 5.25 V. Typical values are at V_{CC} = V_{CP} = 3.3 V, 25 °C.

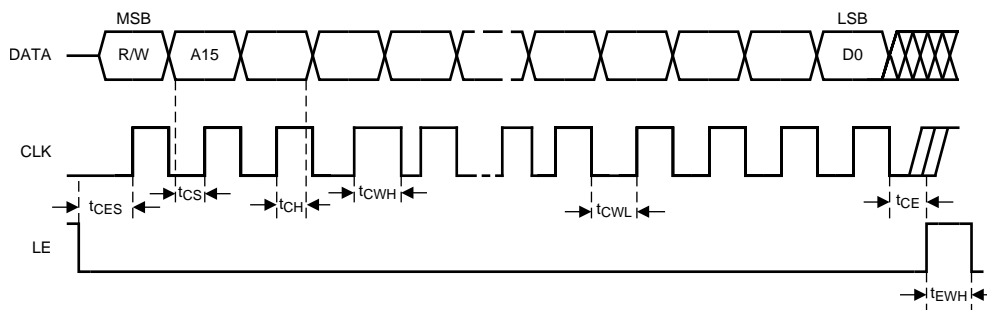
-40°C ≤ T_A ≤ 85 °C for the LMX2492 and -40°C ≤ T_A ≤ 125 °C for the LMX2492-Q1 ; except as specified.)

SYMBOL	PARAMETER	CONDITIONS	MIN	TYP	MAX	UNIT
LOGIC OUTPUT TERMINALS (MUXout,TRIG1,TRIG2,MOD)						
V _{OH}	Output High Voltage		0.8 x V _{CC}	V _{CC}		V
V _{OL}	Output Low Voltage			0	0.2 x V _{CC}	V
LOGIC INPUT TERMINALS (CE,CLK,DATA,LE,MUXout,TRIG1,TRIG2,MOD)						
V _{IH}	Input High Voltage		1.4		V _{CC}	V
V _{IL}	Input Low Voltage		0		0.6	V
I _{IH}	Input Leakage		-5	1	5	uA
T _{CELOW}	Chip enable Low Time		5			us
T _{CEHIGH}	Chip enable High Time		5			us

7.6 Timing Requirements, Programming Interface (CLK, DATA, LE)

		MIN	TYP	MAX	UNIT
T _{CE}	Clock To LE Low Time	10			ns
T _{CS}	Data to Clock Setup Time	4			ns
T _{CH}	Data to Clock Hold Time	4			ns
T _{CWH}	Clock Pulse Width High	10			ns
T _{CWL}	Clock Pulse Width Low	10			ns
T _{CES}	Enable to Clock Setup Time	10			ns
T _{EWH}	Enable Pulse Width High	10			ns

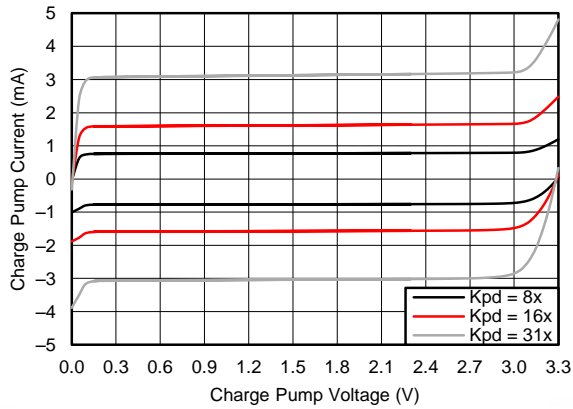
7.7 Serial Data Input Timing



There are several other considerations for programming:

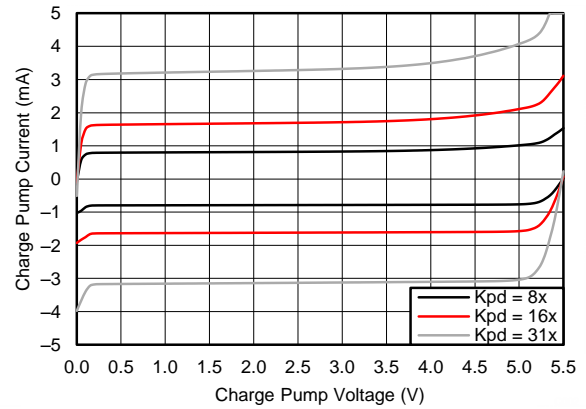
- The DATA is clocked into a shift register on each rising edge of the CLK signal. On the rising edge of the LE signal, the data is sent from the shift register to an actual counter.
- If no LE signal is given after the last data bit and the clock is kept toggling, then these bits will be read into the next lower register. This eliminates the need to send the address each time.
- A slew rate of at least 30 V/us is recommended for the CLK, DATA, and LE signals
- Timing specs also apply to readback. Readback can be done through the MUXout, TRIG1, TRIG2, or MOD terminals.

7.8 Typical Characteristics



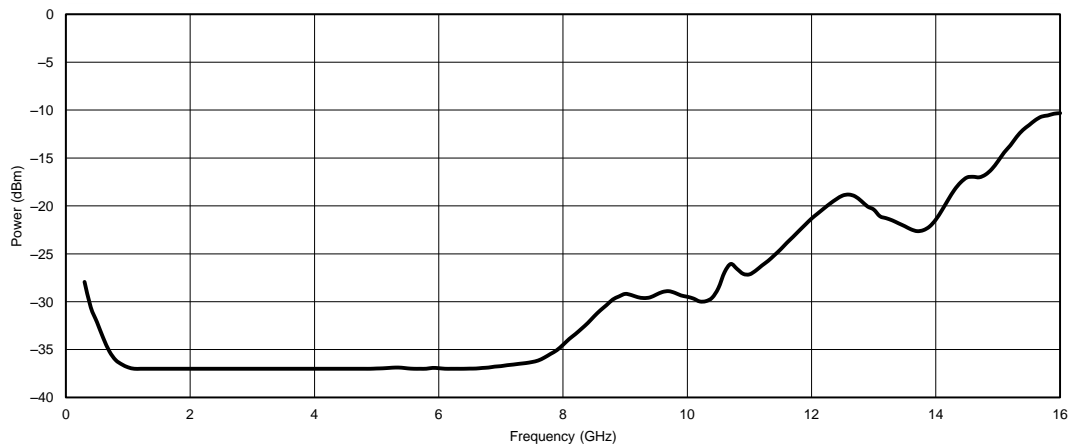
For a charge pump supply of 3.3 V, optimal performance is for a typical charge pump output voltage between 0.5 and 2.8 volts.

Figure 1. Charge Pump Current for Vcp = 3.3 V



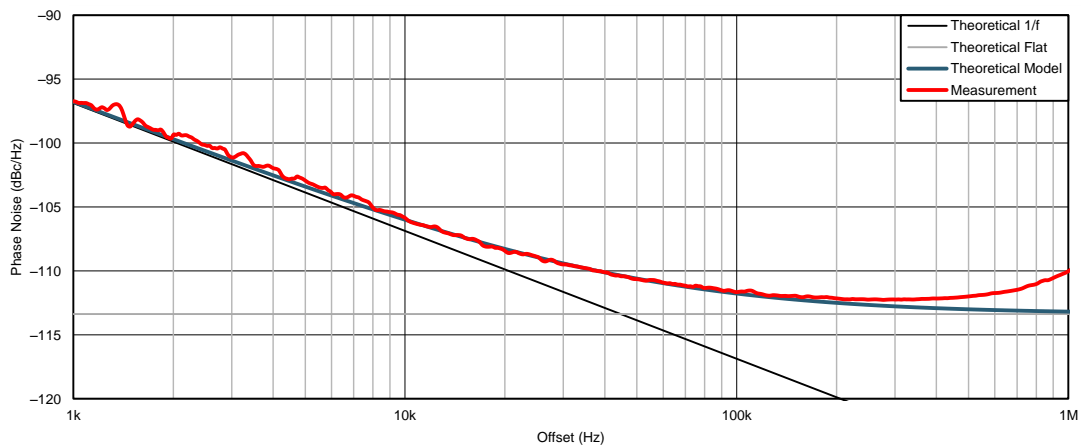
For a charge pump supply voltage of 5 volts or higher, optimal performance is typically for a charge pump output voltage between 0.5 and 4.5 volts.

Figure 2. Charge Pump Current for Vcp = 5.5 V



Typical value of lowest power level as a function of frequency. Design to electrical specifications for input sensitivity, not typical performance graphs.

Figure 3. Fin Input Sensitivity

Typical Characteristics (continued)


This plot is for a phase detector of 100 MHz, 2 MHz loop bandwidth, and VCO at 9600 MHz. However, the plot shown is the divide by 2 port at 4800 MHz. The input was a 100 MHz Wenzel Oscillator. The model shows this phase noise has a figure of merit of -227 dBc/Hz and a normalized 1/f noise of -120.5 dBc/Hz. The charge pump supply was 5 V and the charge pump output voltage was 1.34 V.

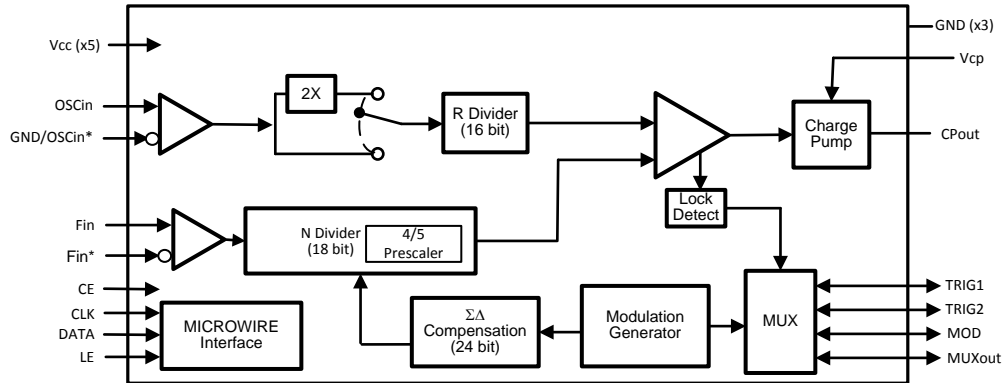
Figure 4. LMX2492/92-Q1 Phase Noise for $F_{pd} = 100$ MHz, $F_{vco} = 9600$ MHz/2

8 Detailed Description

8.1 Overview

The LMX2492/92-Q1 is a microwave PLL, consisting of a reference input and divider, high frequency input and divider, charge pump, ramp generator, and other digital logic. The Vcc power supply pins run at a nominal 3.3 volts, while the charge pump supply pin, Vcp, operates anywhere from Vcc to 5 volts. The device is designed to operate with an external loop filter and VCO. Modulation is achieved by manipulating the MASH engine.

8.2 Functional Block Diagram



8.3 Feature Description

8.3.1 OSCin Input

The reference can be applied in several ways. If using a differential input, this should be terminated differentially with a 100 ohm resistance and AC coupled to the OSCin and GND/OSCin* terminals. If driving this single-ended, then the GND/OSCin* terminal may be grounded, although better performance is attained by connecting the GND/OSCin* terminal through a series resistance and capacitance to ground to match the OSCin terminal impedance.

8.3.2 OSCin Doubler

The OSCin doubler allows the input signal to the OSCin to be doubled in order to have higher phase detector frequencies. This works by clocking on both the rising and falling edges of the input signal, so it therefore requires a 50% input duty cycle.

8.3.3 R Divider

The R counter is 16 bits divides the OSCin signal from 1 to 65535. If DIFF_R = 0, then any value can be chosen in this range. If DIFF_R=1, then the divide is restricted to 2,4,8, and 16, but allows for higher OSCin frequencies.

8.3.4 PLL N Divider

The 16 bit N divider divides the signal at the Fin terminal down to the phase detector frequency. It contains a 4/5 prescaler that creates minimum divide restrictions, but allows the N value to increment in values of one.

Modulator Order	Minimum N Divide
Integer Mode, 1st Order Modulator	16
2nd Order Modulator	17
3rd Order Modulator	19
4th Order Modulator	25

8.3.5 Fractional Circuitry

The fractional circuitry controls the N divider with delta sigma modulation that supports a programmable first, second, third, and fourth order modulator. The fractional denominator is a fully programmable 24-bit denominator that can support any value from 1,2,..., 2^{24} , with the exception when the device is running one of the ramps, and in this case it is a fixed size of 2^{24} .

8.3.6 PLL Phase Detector and Charge Pump

The phase detector compares the outputs of the R and N dividers and generates a correction voltage corresponding to the phase error. This voltage is converted to a correction current by the charge pump. The phase detector frequency, f_{PD} , can be calculated as follows: $f_{PD} = f_{OSCin} \times OSC_2X / R$.

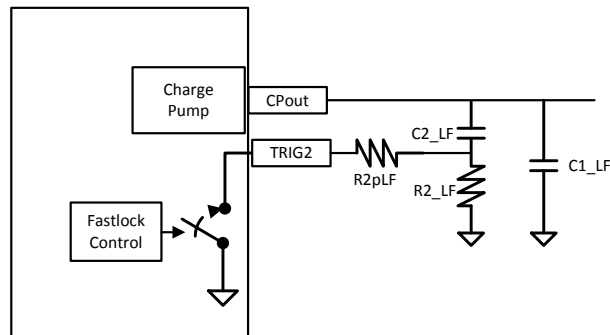
The charge pump supply voltage on this device, V_{cp} , can be either run at the V_{cc} voltage, or up to 5.25 volts in order to get higher tuning voltages to present to the VCO.

8.3.7 External Loop Filter

The loop filter is external to the device and is application specific. Texas Instruments website has details on this at www.ti.com.

8.3.8 Fastlock and Cycle Slip Reduction

The Fastlock™ and Cycle Slip Reduction features can be used to improved lock time. When the frequency is changed, a timeout counter can be used to engage these features for a prescribed number of phase detector cycles. During this time that the timeout counter is counting down, the device can be used to pull a terminal from high impedance to ground switch in an extra resistor (R_{2pLF}), change the charge pump current (FL_CPG), or change the phase detector frequency. TRIG2 is recommended for switching the resistor with a setting of TRIG2_MUX = Fastlock (2) and TRIG2_PIN = Inverted/Open Drain (5).



Parameter	Normal Operation	Fastlock Operation
Charge Pump Gain	CPG	FL_CPG
Device Pin (TRIG1, TRIG2, MOD, or MUXout)	High Impedance	Grounded

The resistor and the charge pump current are changed simultaneously so that the phase margin remains the same while the loop bandwidth is by a factor of K as shown in the following table:

Parameter	Symbol	Calculation
Charge Pump Gain in Fastlock	FL_CPG	Typically use the highest value.
Loop Bandwidth Multiplier	K	$K = \sqrt{FL_CPG / CPG}$
External Resistor	R_{2pLF}	$R2 / (K-1)$

Cycle slip reduction is another method that can also be used to speed up lock time by reducing cycle slipping. Cycle slipping typically occurs when the phase detector frequency exceeds about 100x the loop bandwidth of the PLL. Cycle slip reduction works in a different way than fastlock. To use this, the phase detector frequency is decreased while the charge pump current is simultaneously increased by the same factor. Although the loop bandwidth is unchanged, the ratio of the phase detector frequency to the loop bandwidth is, and this is helpful for cases when the phase detector frequency is high. Because cycle slip reduction changes the phase detector rate, it also impacts other things that are based on the phase detector rate, such as the fastlock timeout-counter and ramping controls.

8.3.9 Lock Detect and Charge Pump Voltage Monitor

The LMX2492/92-Q1 offers two methods to determine if the PLL is in lock, charge pump voltage monitoring and digital lock detect. These features can be used individually or in conjunction to give a reliable indication of when the PLL is in lock. The output of this detection can be routed to the TRIG1, TRIG2, MOD, or MUXout terminals.

8.3.9.1 Charge Pump Voltage Monitor

The charge pump voltage monitor allows the user to set low (CMP_THR_LOW) and high (CMP_THR_HIGH) thresholds for a comparator that monitors the charge pump output voltage.

Vcp	Threshold	Suggested Level
3.3 V	CPM_THR_LOW = (Vthresh + 0.08) / 0.085	6 for 0.5V limit
	CPM_THR_HIGH = (Vthresh - 0.96) / 0.044	42 for 2.8V limit
5.0 V	CPM_THR_LOW = (Vthresh + 0.056) / 0.137	4 for 0.5V limit
	CPM_THR_HIGH = (Vthresh - 1.23) / 0.071	46 for 4.5V limit

8.3.9.2 Digital Lock Detect

Digital lock detect works by comparing the phase error as presented to the phase detector. If the phase error plus the delay as specified by the PFD_DLY bit is outside the tolerance as specified by DLD_TOL, then this comparison would be considered to be an error, otherwise passing. The DLD_ERR_CNT specifies how many errors are necessary to cause the circuit to consider the PLL to be unlocked. The DLD_PASS_CNT specifies how many passing comparisons are necessary to cause the PLL to be considered to be locked and also resets the count for the errors. The DLD_TOL value should be set to no more than half of a phase detector period plus the PFD_DLY value. The DLD_ERR_CNT and DLD_PASS_CNT values can be decreased to make the circuit more sensitive. If the circuit is too sensitive, then chattering can occur and the DLD_ERR_CNT, DLD_PASS_CNT, or DLD_TOL values should be increased.

Note that if the OSCin signal goes away and there is no noise or self-oscillation at the OSCin pin, then it is possible for the digital lock detect to indicate a locked state when the PLL really is not in lock. If this is a concern, then digital lock detect can be combined with charge pump voltage monitor to detect this situation..

8.3.10 FSK/PSK Modulation

Two level FSK or PSK modulation can be created whenever a trigger event, as defined by the FSK_TRIG field is detected. This trigger can be defined as a transition on a terminal (TRIG1, TRIG2, MOD, or MUXout) or done purely in software. The RAMP_PM_EN bit defines the modulation to be either FSK or PSK and the FSK_DEV register determines the amount of the deviation. Remember that the FSK_DEV[32:0] field is programmed as the 2's complement of the actual desired FSK_DEV value. This modulation can be added to the modulation created from the ramping functions as well.

RAMP_PM_EN	Modulation Type	Deviation
0	2 Level FSK	$F_{pd} \times FSK_DEV / 2^{24}$
1	2 Level PSK	$360^\circ \times FSK_DEV / 2^{24}$

8.3.11 Ramping Functions

The LMX2492/92-Q1 supports a broad and flexible class of FMCW modulation formed by up to 8 linear ramps. When the ramping function is running, the denominator is fixed to a forced value of $2^{24} = 16777216$. The waveform always starts at RAMP0 when the LSB of the PLL_N (R16) is written to. After it is set up, it will start at the initial frequency and have piecewise linear frequency modulation that deviates from this initial frequency as specified by the modulation. Each of the eight ramps can be individually programmed. Various settings are as follows

Ramp Characteristic	Programming Field Name	Description
Ramp Length	RAMPx_LEN RAMPx_DLY	The user programs the length of the ramp in phase detector cycles. If RAMPx_DLY=1, then each count of RAMPx_LEN is actually two phase detector cycles.
Ramp Slope	RAMPx_LEN RAMPx_DLY RAMPx_INC	The user does not directly program slope of the line, but rather this is done by defining how long the ramp is and how much the fractional numerator is increased per phase detector cycle. The value for RAMPx_INC is calculated by taking the total expected increase in the frequency, expressed in terms of how much the fractional numerator increases, and dividing it by RAMPx_LEN. The value programmed into RAMPx_INC is actually the two's complement of the desired mathematical value.
Trigger for Next Ramp	RAMPx_NEXT_TRIG	The event that triggers the next ramp can be defined to be the ramp finishing or can wait for a trigger as defined by TRIG A, TRIG B, or TRIG C.
Next Ramp	RAMPx_NEXT	This sets the ramp that follows. Waveforms are constructed by defining a chain ramp segments. To make the waveform repeat, make RAMPx_NEXT point to the first ramp in the pattern.
Ramp Fastlock	RAMPx_FL	This allows the ramp to use a different charge pump current or use Fastlock
Ramp Flags	RAMPx_FLAG	This allows the ramp to set a flag that can be routed to external terminals to trigger other devices.

8.3.11.1 Ramp Count

If it is desired that the ramping waveform keep repeating, then all that is needed is to make the RAMPx_NEXT of the final ramp equal to the first ramp. This will run until the RAMP_EN bit is set to zero. If this is not desired, then one can use the RAMP_COUNT to specify how many times the specified pattern is to repeat.

8.3.11.2 Ramp Comparators and Ramp Limits

The ramp comparators and ramp limits use programmable thresholds to allow the device to detect whenever the modulated waveform frequency crosses a limit as set by the user. The difference between these is that comparators set a flag to alert the user while a ramp limits prevent the frequency from going beyond the prescribed threshold. In either case, these thresholds are expressed by programming the Extended_Fractional_Numerator.

$$\text{Extended_Fractional_Numerator} = \text{Fractional_Numerator} + (N-N^*) \times 2^{24}$$

In the above, N is the PLL feedback value without ramping and N* is the instantaneous value during ramping. The actual value programmed is the 2's complement of Extended_Fractional_Numerator.

Type	Programming Bit	Threshold
Ramp Limits	RAMP_LIMIT_LOW	Lower Limit
	RAMP_LIMIT_HIGH	Upper Limit
Ramp Comparators	RAMP_CMP0 RAMP_CMP1	For the ramp comparators, if the ramp is increasing and exceeds the value as specified by RAMP_CMPx, then the flag will go high, otherwise it is low. If the ramp is decreasing and goes below the value as specified by RAMP_CMPx, then the flag will go high, otherwise it will be low.

8.3.12 Power on Reset (POR)

The power on reset circuitry sets all the registers to a default state when the device is powered up. This same reset can be done by programming SWRST=1. In the programming section, the power on reset state is given for all the programmable fields.

8.4 Device Functional Modes

The two primary ways to use the LMX2492/92-Q1 are to run it to generate a set of frequencies

8.4.1 Continuous Frequency Generator

In this mode, the LMX2492/92-Q1 generates a single frequency that only changes when the N divider is programmed to a new value. In this mode, the RAMP_EN bit is set to 0 and the ramping controls are not used. The fractional denominator can be programmed to any value from 1 to 16777216. In this kind of application, the PLL is tuned to different channels, but at each channel, the goal is to generate a stable fixed frequency.

8.4.1.1 Integer Mode Operation

In integer mode operation, the VCO frequency needs to be an integer multiple of the phase detector frequency. This can be the case when the output frequency or frequencies are nicely related to the input frequency. As a rule of thumb, if this can be done with a phase detector of as high as the lesser of 10 MHz or the OSCin frequency, then this makes sense. To operate the device in integer mode, disable the fractional circuitry by programming the fractional order (FRAC_ORDER), dithering (FRAC_DITH), and numerator (FRAC_NUM) to zero.

8.4.1.2 Fractional Mode Operation

In fractional mode, the output frequency does not need to be an integer multiple of the phase detector frequency. This makes sense when the channel spacing is more narrow or the input and output frequencies are not nicely related. There are several programmable controls for this such as the modulator order, fractional dithering, fractional numerator, and fractional denominator. There are many trade-offs with choosing these, but here are some guidelines

Parameter	Field Name	How to Choose
Fractional Numerator and Denominator	FRAC_NUM FRAC_DEN	The first step is to find the fractional denominator. To do this, find the frequency that divides the phase detector frequency by the channel spacing. For instance, if the output ranges from 5000 to 5050 in 5 MHz steps and the phase detector is 100 MHz, then the fractional denominator is $100 \text{ MHz} / 5 = 20$. So for an output of 5015 MHz, the N divider would be $50 + 3/20$. In this case, the fractional numerator is 3 and the fractional denominator is 20. Sometimes when dithering is used, it makes sense to express this as a larger equivalent fraction. Note that if ramping is active, the fractional denominator is forced to 2^{24} .
Fractional Order	FRAC_ORDER	There are many trade-offs, but in general try either the 2nd or 3rd order modulator as starting points. The 3rd order modulator may give lower main spurs, but may generate others. Also if dithering is involved, it can generate phase noise.
Dithering	FRAC_DITH	Dithering can reduce some fractional spurs, but add noise. Consult application note AN-1879 for more details on this.

8.4.2 Modulated Waveform Generator

In this mode, the device can generate a broad class of frequency sweeping waveforms. The user can specify up to 8 linear segments in order to generate these waveforms. When the ramping function is running, the denominator is fixed to a forced value of $2^{24} = 16777216$

In addition to the ramping functions, there is also the capability to use a terminal to add phase or frequency modulation that can be done by itself or added on top of the waveforms created by the ramp generation functions.

8.5 Programming

8.5.1 Loading Registers

The device is programmed using several 24 bit registers. The first 16 bits of the register are the address, followed by the next 8 bits of data. The user has the option to pull the LE terminal high after this data, or keep sending data and it will apply this data to the next lower register. So instead of sending three registers of 24 bits each, one could send a single 40 bit register with the 16 bits of address and 24 bits of data. For that matter, the entire device could be programmed as a single register if desired.

8.6 Register Map

Registers are programmed in REVERSE order from highest to lowest. Registers NOT shown in this table or marked as reserved can be written as all 0's unless otherwise stated. The POR value is the power on reset value that is assigned when the device is powered up or the SWRST bit is asserted.

Table 1. Register Map

Register		D7	D6	D5	D4	D3	D2	D1	D0	POR	
0	0	0	0	0	1	1	0	0	0	0x18	
1	0x1	Reserved								0x00	
2	0x2	0	0	0	0	0	SWRST	POWERDOWN[1:0]		0x00	
3-15	0x3 - 0xF	Reserved								-	
16	0x10	PLL_N[7:0]								0x64	
17	0x11	PLL_N[15:8]								0x00	
18	0x12	0	FRAC_ORDER[2:0]			FRAC_DITHER[1:0]		PLL_N[17:16]		0x00	
19	0x13	FRAC_NUM[7:0]								0x00	
20	0x14	FRAC_NUM[15:8]								0x00	
21	0x15	FRAC_NUM[23:16]								0x00	
22	0x16	FRAC_DEN[7:0]								0x00	
23	0x17	FRAC_DEN[15:8]								0x00	
24	0x18	FRAC_DEN[23:16]								0x00	
25	0x19	PLL_R[7:0]								0x04	
26	0x1A	PLL_R[15:8]								0x00	
27	0x1B	0	FL_CSR[1:0]		PFD_DLY[1:0]		PLL_R_DIFF	0	OSC_2X	0x08	
28	0x1C	0	0	CPPOL	CPG[4:0]					0x00	
29	0x1D	FL_TOC[10:8]			FL_CPG[4:0]					0x00	
30	0x1E	0	CPM_FLAGL	CPM_THR_LOW[5:0]						0x0a	
31	0x1F	0	CPM_FLAGH	CPM_THR_HIGH[5:0]						0x32	
32	0x20	FL_TOC[7:0]								0x00	
33	0x21	DLD_PASS_CNT[7:0]								0x0f	
34	0x22	DLD_TOL[2:0]			DLD_ERR_CNTR[4:0]					0x00	
35	0x23	MOD_MUX[5]	1	MUXout_MUX[5]	TRIG2_MUX[5]	TRIG1_MUX[5]	0	0	1	0x41	
36	0x24	TRIG1_MUX[4:0]					TRIG1_PIN[2:0]				0x08
37	0x25	TRIG2_MUX[4:0]					TRIG2_PIN[2:0]				0x10
38	0x26	MOD_MUX[4:0]					MOD_PIN[2:0]				0x18
39	0x27	MUXout_MUX[4:0]					MUXout_PIN[2:0]				0x38
40-57	0x28-0x39	Reserved								-	

Register Map (continued)
Table 1. Register Map (continued)

Register		D7	D6	D5	D4	D3	D2	D1	D0	POR	
58	0x3A	RAMP_TRIG_A[3:0]				0	RAMP_PM_EN	RAMP_CLK	RAMP_EN	0x00	
59	0x3B	RAMP_TRIG_C[3:0]			RAMP_TRIG_B[3:0]					0x00	
60	0x3C	RAMP_CMP0[7:0]								0x00	
61	0x3D	RAMP_CMP0[15:8]								0x00	
62	0x3E	RAMP_CMP0[23:16]								0x00	
63	0x3F	RAMP_CMP0[31:24]								0x00	
64	0x40	RAMP_CMP0_EN[7:0]								0x00	
65	0x41	RAMP_CMP1[7:0]								0x00	
66	0x42	RAMP_CMP1[15:8]								0x00	
67	0x43	RAMP_CMP1[23:16]								0x00	
68	0x44	RAMP_CMP1[31:24]								0x00	
69	0x45	RAMP_CMP1_EN[7:0]								0x00	
70	0x46	0	FSK_TRIG[1:0]	RAMP_LIMH[32]	RAMP_LIML[32]	FSK_DEV[32]	RAMP_CMP1[32]	RAMP_CMP0[32]		0x08	
71	0x47	FSK_DEV[7:0]								0x00	
72	0x48	FSK_DEV[15:8]								0x00	
73	0x49	FSK_DEV[23:16]								0x00	
74	0x4A	FSK_DEV[31:24]								0x00	
75	0x4B	RAMP_LIMIT_LOW[7:0]								0x00	
76	0x4C	RAMP_LIMIT_LOW[15:8]								0x00	
77	0x4D	RAMP_LIMIT_LOW[23:16]								0x00	
78	0x4E	RAMP_LIMIT_LOW[31:24]								0x00	
79	0x4F	RAMP_LIMIT_HIGH[7:0]								0xff	
80	0x50	RAMP_LIMIT_HIGH[15:8]								0xff	
81	0x51	RAMP_LIMIT_HIGH[23:16]								0xff	
82	0x52	RAMP_LIMIT_HIGH[31:24]								0xff	
83	0x53	RAMP_COUNT[7:0]								0x00	
84	0x54	RAMP_TRIG_INC[1:0]	RAMP_AUTO	RAMP_COUNT[12:8]							0x00
85	0x55	Reserved								0x00	

Register Map (continued)
Table 1. Register Map (continued)

Register		D7	D6	D5	D4	D3	D2	D1	D0	POR
86	0x56	RAMP0_INC[7:0]								0x00
87	0x57	RAMP0_INC[15:8]								0x00
88	0x58	RAMP0_INC[23:16]								0x00
89	0x59	RAMP0_DLY	RAMP0_FL	RAMP0_INC[29:24]						0x00
90	0x5A	RAMP0_LEN[7:0]								0x00
91	0x5B	RAMP0_LEN[15:8]								0x00
92	0x5C	RAMP0_NEXT[2:0]			RAMP0_NEXT_TRIG[1:0]		RAMP0_RST	RAMP0_FLAG[1:0]		0x00
93	0x5D	RAMP1_INC[7:0]								0x00
94	0x5E	RAMP1_INC[15:8]								0x00
95	0x5F	RAMP1_INC[23:16]								0x00
96	0x60	RAMP1_DLY	RAMP1_FL	RAMP1_INC[29:24]						0x00
97	0x61	RAMP1_LEN[7:0]								0x00
98	0x62	RAMP1_LEN[15:8]								0x00
99	0x63	RAMP1_NEXT[2:0]			RAMP1_NEXT_TRIG[1:0]		RAMP1_RST	RAMP1_FLAG[1:0]		0x00
100	0x64	RAMP2_INC[7:0]								0x00
101	0x65	RAMP2_INC[15:8]								0x00
102	0x66	RAMP2_INC[23:16]								0x00
103	0x67	RAMP2_DLY	RAMP2_FL	RAMP2_INC[29:24]						0x00
104	0x68	RAMP2_LEN[7:0]								0x00
105	0x69	RAMP2_LEN[15:8]								0x00
106	0x6A	RAMP2_NEXT[2:0]			RAMP2_NEXT_TRIG[1:0]		RAMP2_RST	RAMP2_FLAG[1:0]		0x00
107	0x6B	RAMP3_INC[7:0]								0x00
108	0x6C	RAMP3_INC[15:8]								0x00
109	0x6D	RAMP3_INC[23:16]								0x00
110	0x6E	RAMP3_DLY	RAMP3_FL	RAMP3_INC[29:24]						0x00
111	0x6F	RAMP3_LEN[7:0]								0x00
112	0x70	RAMP3_LEN[15:8]								0x00
113	0x71	RAMP3_NEXT[2:0]			RAMP3_NEXT_TRIG[1:0]		RAMP3_RST	RAMP3_FLAG[1:0]		0x00

Register Map (continued)
Table 1. Register Map (continued)

Register		D7	D6	D5	D4	D3	D2	D1	D0	POR
114	0x72	RAMP4_INC[7:0]								0x00
115	0x73	RAMP4_INC[15:8]								0x00
116	0x74	RAMP4_INC[23:16]								0x00
117	0x75	RAMP4_DLY	RAMP4_FL	RAMP4_INC[29:24]						0x00
118	0x76	RAMP4_LEN[7:0]								0x00
119	0x77	RAMP4_LEN[15:8]								0x00
120	0x78	RAMP4_NEXT[2:0]			RAMP4_NEXT_TRIG[1:0]		RAMP4_RST	RAMP4_FLAG[1:0]		0x00
121	0x79	RAMP5_INC[7:0]								0x00
122	0x7A	RAMP5_INC[15:8]								0x00
123	0x7B	RAMP5_INC[23:16]								0x00
124	0x7C	RAMP5_DLY	RAMP5_FL	RAMP5_INC[29:24]						0x00
125	0x7D	RAMP5_LEN[7:0]								0x00
126	0x7E	RAMP5_LEN[15:8]								0x00
127	0x7F	RAMP5_NEXT[2:0]			RAMP5_NEXT_TRIG[1:0]		RAMP5_RST	RAMP5_FLAG[1:0]		0x00
128	0x80	RAMP6_INC[7:0]								0x00
129	0x81	RAMP6_INC[15:8]								0x00
130	0x82	RAMP6_INC[23:16]								0x00
131	0x83	RAMP6_DLY	RAMP6_FL	RAMP6_INC[29:24]						0x00
132	0x84	RAMP6_LEN[7:0]								0x00
133	0x85	RAMP6_LEN[15:8]								0x00
134	0x86	RAMP6_NEXT[2:0]			RAMP6_NEXT_TRIG[1:0]		RAMP6_RST	RAMP6_FLAG[1:0]		0x00
135	0x87	RAMP7_INC[7:0]								0x00
136	0x88	RAMP7_INC[15:8]								0x00
137	0x89	RAMP7_INC[23:16]								0x00
138	0x8A	RAMP7_DLY	RAMP7_FL	RAMP7_INC[29:24]						0x00
139	0x8B	RAMP7_LEN[7:0]								0x00
140	0x8C	RAMP7_LEN[15:8]								0x00
141	0x8D	RAMP7_NEXT[2:0]			RAMP7_NEXT_TRIG[1:0]		RAMP7_RST	RAMP7_FLAG[1:0]		0x00
142-32767	0x8E-0x7ff	Reserved								0x00

8.7 Register Field Descriptions

The following sections go through all the programmable fields and their states. Additional information is also available in the applications and feature descriptions sections as well. The POR column is the power on reset state that this field assumes if not programmed.

8.7.1 POWERDOWN and Reset Fields

Table 2. POWERDOWN and Reset Fields

Field	Location	POR	Description and States		
POWERDOWN [1:0]	R2[1:0]	0	POWERDOWN Control	Value	POWERDOWN State
				0	POWERDOWN, ignore CE
				1	Power Up, ignore CE
				2	Power State Defined by CE terminal state
				3	Reserved
SWRST	R2[2]	0	Software Reset. Setting this bit sets all registers to their POR default values.	Value	Reset State
				0	Normal Operation
				1	Register Reset

8.7.2 Dividers and Fractional Controls

Table 3. Dividers and Fractional Controls

Field	Location	POR	Description and States		
PLL_N [17:0]	R18[1] to R16[0]	16	Feedback N counter Divide value. Minimum count is 16. Maximum is 262132. Writing of the register R16 begins any ramp execution when RAMP_EN=1.		
FRAC_DITHER [1:0]	R18[3:2]	0	Dither used by the fractional modulator	Value	Dither
				0	Weak
				1	Medium
				2	Strong
FRAC_ORDER [2:0]	R18[6:4]	0	Fractional Modulator order	Value	Modulator Order
				0	Integer Mode
				1	1st Order Modulator
				2	2nd Order Modulator
				3	3rd Order Modulator
4	4th Order Modulator				
5-7	Reserved				
FRAC_NUM [23:0]	R21[7] to R19[0]	0	Fractional Numerator. This value should be less than or equal to the fractional denominator.		
FRAC_DEN [23:0]	R24[7] to R22[0]	0	Fractional Denominator. If the RAMP_EN=1, this field is ignored and the denominator is fixed to 2 ²⁴ .		
PLL_R [15:0]	R26[7] to R25[0]	1	Reference Divider value. Selecting 1 will bypass counter.		
OSC_2X	R27[0]	0	Enables the Doubler before the Reference divider	Value	Doubler
				0	Disabled
1	Enabled				
PLL_R_DIFF	R27[2]	0	Enables the Differential R counter. This allows for higher OSCin frequencies, but restricts PLL_R to divides of 2,4,8 or 16.	Value	R Divider
				0	Single-Ended
1	Differential				
PFD_DLY [1:0]	R27[4:3]	1	Sets the charge pump minimum pulse width. This could potentially be a trade-off between fractional spurs and phase noise. Setting 1 is recommended for general use.	Value	Pulse Width
				0	Reserved
				1	860 ps
				2	1200 ps
3	1500 ps				
CPG [4:0]	R28[4:0]	0	Charge pump gain	Value	Charge Pump State
				0	Tri-State
				1	100 uA
				2	200 uA
			
31	3100 uA				
CPPOL	R28[5]	0	Charge Pump Polarity Positive is for a positive slope VCO characteristic, negative otherwise.	Value	Charge Pump Polarity
				0	Negative
1	Positive				

8.7.2.1 Speed Up Controls (Cycle Slip Reduction and Fastlock)
Table 4. FastLock and Cycle Slip Reduction

Field	Location	POR	Description and States		
FL_CSR [1:0]	R27[6:5]	0	Cycle Slip Reduction (CSR) reduces the phase detector frequency by multiplying both the R and N counters by the CSR value while either the FastLock Timer is counting or the RAMPx_FL=1 and the part is ramping. Care must be taken that the R and N divides remain inside the range of the counters. Cycle slip reduction is generally not recommended during ramping.	Value	CSR Value
				0	Disabled
				1	x 2
				2	x 4.
				3	Reserved
FL_CPG [4:0]	R29[4:0]	0	Charge pump gain only when Fast Lock Timer is counting down or a ramp is running with RAMPx_FL=1	Value	Fastlock Charge Pump Gain
				0	Tri-State
				1	100 uA
				2	200 uA
			
31	3100 uA				
FL_TOC [10:0]	R29[7:5] and R32[7:0]	0	Fast Lock Timer. This counter starts counting when the user writes the PLL_N(Register R16). During this time the FL_CPG gain is sent to the charge pump, and the FL_CSR shifts the R and N counters if enabled. When the counter terminates, the normal CPG is presented and the CSR undo's the shifts to give a normal PFD frequency.	Value	Fastlock Timer Value
				0	Disabled
				1	1 x 32 = 32
				...	
2047	2047 x 32 = 65504				

8.8 Lock Detect and Charge Pump Monitoring

Table 5. Lock Detect and Charge Pump Monitor

Field	Location	POR	Description and States		
CPM_THR_LOW [5:0]	R30[5:0]	0x0A	Charge pump voltage low threshold value. When the charge pump voltage is below this threshold, the LD goes low.	Value	Threshold
				0	Lowest
				63	Highest
CPM_FLAGL	R30[6]	-	This is a read only bit. Low indicates the charge pump voltage is below the minimum threshold.	Value	Flag Indication
				0	Charge pump is below CPM_THR_LOW threshold
CPM_THR_HIGH [5:0]	R31[5:0]	0x32	Charge pump voltage high threshold value. When the charge pump voltage is above this threshold, the LD goes low.	Value	Threshold
				0	Lowest
				63	Highest
CPM_FLAGH	R31[6]	-	This is a read only bit. Charge pump voltage high comparator reading. High indicates the charge pump voltage is above the maximum threshold.	Value	Threshold
				0	Charge pump is below CPM_THR_HIGH threshold
CPM_FLAGH	R31[6]	-	This is a read only bit. Charge pump voltage high comparator reading. High indicates the charge pump voltage is above the maximum threshold.	1	Charge pump is above CPM_THR_HIGH threshold
DLD_PASS_CNT [7:0]	R33[7:0]	0xff	Digital Lock Detect Filter amount. There must be at least DLD_PASS_CNT good edges and less than DLD_ERR edges before the DLD is considered in lock. Making this number smaller will speed the detection of lock, but also will allow a higher chance of DLD chatter.		
DLD_ERR_CNT [4:0]	R34[4:0]	0	Digital Lock Detect error count. This is the maximum number of errors greater than DLD_TOL that are allowed before DLD is de-asserted. Although the default is 0, the recommended value is 4.		
DLD_TOL [2:0]	R34[7:5]	0	Digital Lock detect edge window. If both N and R edges are within this window, it is considered a "good" edge. Edges that are farther apart in time are considered "error" edges. Window choice depends on phase detector frequency, charge pump minimum pulse width, fractional modulator order and the users desired margin.	Value	Window and Fpd Frequency
				0	1 ns (Fpd > 130 MHz)
				1	1.7 ns (80 MHz , Fpd ≤ 130 MHz)
				2	3 ns (60 MHz , Fpd ≤ 80 MHz)
				3	6 ns (45 MHz , Fpd ≤ 60 MHz)
				4	10 ns (30 MHz < Fpd ≤ 45 MHz)
				5	18 ns (Fpd ≤ 30 MHz)
6 and 7	Reserved				

8.9 TRIG1,TRIG2,MOD, and MUXout Pins

Table 6. TRIG1, TRIG2, MOD, and MUXout Terminal States

Field	Location	POR	Description and States		
			Value	Pin Drive State	
TRIG1_PIN [2:0]	R36[2:0]	0	0	TRISTATE (default)	
			1	Open Drain Output	
			2	Pullup / Pulldown Output	
TRIG2_PIN [2:0]	R37[2:0]	0	This is the terminal drive state for the TRIG1, TRIG2, MOD, and MUXout Pins	3	Reserved
MOD_PIN [2:0]	R38[2:0]	0		4	GND
MUXout_PIN [2:0]	R39[2:0]	0		5	Inverted Open Drain Output
				6	Inverted Pullup / Pulldown Output
				7	Input

Table 7. TRIG1, TRIG2, MOD, and MUXout Selections

Field	Location	POR	Description and States			
			Value	MUX State		
				0	GND	
				1	Input TRIG1	
				2	Input TRIG2	
				3	Input MOD	
				4	Output TRIG1 after synchronizer	
				5	Output TRIG2 after synchronizer	
				6	Output MOD after synchronizer	
				7	Output Read back	
				8	Output CMP0	
				9	Output CMP1	
				10	Output LD (DLD good AND CPM good)	
				11	Output DLD	
				12	Output CPMON good	
				13	Output CPMON too High	
				14	Output CPMON too low	
				15	Output RAMP LIMIT EXCEEDED	
				16	Output R Divide/2	
				17	Output R Divide/4	
				18	Output N Divide/2	
				19	Output N Divide/4	
				20	Reserved	
				21	Reserved	
				22	Output CMP0RAMP	
				23	Output CMP1RAMP	
				24	Reserved	
				25	Reserved	
				26	Reserved	
				27	Reserved	
				28	Output Faslock	
				29	Output CPG from RAMP	
				30	Output Flag0 from RAMP	
				31	Output Flag1 from RAMP	
				32	Output TRIGA	
				33	Output TRIGB	
				34	Output TRIGC	
				35	Output R Divide	
				36	Output CPUP	
				37	Output CPDN	
				38	Output RAMP_CNT Finished	
				39 to 63	Reserved	
TRIG1_MUX [5:0]	R36[7:3], R37.3		These fields control what signal is muxed to or from the TRIG1, TRIG2, MOD, and MUXout pins. Some of the abbreviations used are: COMP0, COMP1: Comparators 0 and 1 LD, DLD: Lock Detect, Digital Lock Detect CPM: Charge Pump Monitor CPG: Charge Pump Gain CPUP: Charge Pump Up Pulse CPDN: Charge Pump Down Pulse			
TRIG2_MUX [5:0]	R36[7:3], R35.3	1				
MOD_MUX [5:0]	R37[7:3], R35.4	2				
MUXout_MUX [5:0]	R38[7:3], R35.7	3 7				

8.10 Ramping Functions

Table 8. Ramping Functions

Field	Location	POR	Description and States		
RAMP_EN	R58[0]	0	Enables the RAMP functions. When this bit is set, the Fractional Denominator is fixed to 2 ²⁴ . RAMP execution begins at RAMP0 upon the PLL_N[7:0] write. The Ramp should be set up before RAMP_EN is set.	Value	Ramp
				0	Disabled
RAMP_CLK	R58[1]	0	RAMP clock input source. The ramp can be clocked by either the phase detector clock or the MOD terminal based on this selection.	Value	Source
				0	Phase Detector
RAMP_PM_EN	R58[2]	0	Phase modulation enable.	Value	Modulation Type
				0	Frequency Modulation
RAMP_TRIGA [3:0] RAMP_TRIGB [3:0] RAMP_TRIGC [3:0]	R58[7:4] R59[3:0] R59[7:4]	0	Trigger A,B, and C Sources	Value	Source
				0	Never Triggers (default)
				1	TRIG1 terminal rising edge
				2	TRIG2 terminal rising edge
				3	MOD terminal rising edge
				4	DLD Rising Edge
				5	CMP0 detected (level)
				6	RAMPx_CPG Rising edge
				7	RAMPx_FLAG0 Rising edge
				8	Always Triggered (level)
				9	TRIG1 terminal falling edge
				10	TRIG2 terminal falling edge
				11	MOD terminal falling edge
				12	DLD Falling Edge
				13	CMP1 detected (level)
14	RAMPx_CPG Falling edge				
15	RAMPx_FLAG0 Falling edge				
RAMP_CMP0 [32:0]	R70[0], R63[7] to R60[0]	0	Twos compliment of Ramp Comparator 0 value. Be aware of that the MSB is in Register R70.		
RAMP_CMP0_EN [7:0]	R64[7:0]	0	Comparator 0 is active during each RAMP corresponding to the bit. Place a 1 for ramps it is active in and 0 for ramps it should be ignored. RAMP0 corresponds to R64[0], RAMP7 corresponds to R64[7]		
RAMP_CMP1 [32:0]	R70[1], R68[7] to R65[0]	0	Twos compliment of Ramp Comparator 1 value. Be aware of that the MSB is in Register R70.		
RAMP_CMP1_EN [7:0]	R69[7:0]	0	Comparator 1 is active during each RAMP corresponding to the bit. Place a 1 for ramps it is active in and 0 for ramps it should be ignored. RAMP0 corresponds to R64[0], RAMP7 corresponds to R64[7].		
FSK_TRIG [1:0]	R76[4] to R75[3]	0	Deviation trigger source. When this trigger source specified is active, the FSK_DEV value is applied.	Value	Trigger
				0	Always Triggered
				1	Trigger A
				2	Trigger B
				3	Trigger C
FSK_DEV [32:0]	R70[2], R74[7] to R71[0]	0	Twos compliment of the deviation value for frequency modulation and phase modulation. This value should be written with 0 when not used. Be aware that the MSB is in Register R70.		

Ramping Functions (continued)
Table 8. Ramping Functions (continued)

Field	Location	POR	Description and States		
RAMP_LIMIT_LOW [32:0]	R70[3], R78[7] to 75[0]	0x000 00000	Two's complement of the ramp lower limit that the ramp can not go below. The ramp limit occurs before any deviation values are included. Care must be taken if the deviation is used and the ramp limit must be set appropriately. Be aware that the MSB is in Register R70.		
RAMP_LIMIT_HIGH [32:0]	R70[4], R82[7] to 79.0[0]	0xfffff f	Two's complement of the ramp higher limit that the ramp can not go above. The ramp limit occurs before any deviation values are included. Care must be taken if the deviation is used and the ramp limit must be set appropriately. Be aware that the MSB is in Register R70.		
RAMP_COUNT [12:0]	R84[4] to R83[0]	0	Number of RAMPs that will be executed before a trigger or ramp enable is brought down. Load zero if this feature is not used. Counter is automatically reset when RAMP_EN goes from 0 to 1.		
RAMP_AUTO	R84[5]	0	Automatically clear RAMP_EN when RAMP Count hits terminal count.	Value	Ramp
				0	RAMP_EN unaffected by ramp counter (default)
				1	RAMP_EN automatically brought low when ramp counter terminal counts
RAMP_TRIG_INC [1:0]	R84[7:6]	0	Increment Trigger source for RAMP Counter. To disable ramp counter, load a count value of 0.	Value	Source
				0	Increments occur on each ramp transition
				1	Increment occurs on trigA
				2	Increment occurs on trigB
				3	Increment occurs on trigC

8.11 Individual Ramp Controls

These bits apply for all eight ramps. For the field names, x can be 0,1,2,3,4,5,6, or 7.

Table 9. Individual Ramp Controls

Field	Location	POR	Description and States		
RAMPx_INC[29:0]	Varies	0	Signed ramp increment.		
RAMPx_FL	Varies	0	This enables fastlock and cycle slip reduction for ramp x.	Value	CPG
				0	Disabled
				1	Enabled
RAMPx_DLY	Varies	0	During this ramp, each increment takes 2 PFD cycles per LEN clock instead of the normal 1 PFD cycle. Slows the ramp by a factor of 2.	Value	Clocks
				0	1 PFD clock per RAMP tick.(default)
				1	2 PFD clocks per RAMP tick.
RAMPx_LEN	Varies	0	Number of PFD clocks (if DLY is 0) to continue to increment RAMP. 1=>1 cycle, 2=>2 etc. Maximum of 65536 cycles.		
RAMPx_FLAG[1:0]	Varies	0	General purpose FLAGS sent out of RAMP.	Value	Flag
				0	Both FLAG1 and FLAG0 are zero. (default)
				1	FLAG0 is set, FLAG1 is clear
				2	FLAG0 is clear, FLAG1 is set
RAMP0_RST	Varies	0	Forces a clear of the ramp accumulator. This is used to erase any accumulator creep that can occur depending on how the ramps are defined. Should be done at the start of a ramp pattern.	Value	Reset
				0	Disabled
				1	Enabled
RAMPx_NEXT_TRIG [1:0]	Varies	0	Determines what event is necessary to cause the state machine to go to the next ramp. It can be set to when the RAMPx_LEN counter reaches zero or one of the events for Triggers A,B, or C.	Value	Operation
				0	RAMPx_LEN
				1	TRIG_A
				2	TRIG_B
RAMP0_NEXT[2:0]	Varies	0	The next RAMP to execute when the length counter times out		

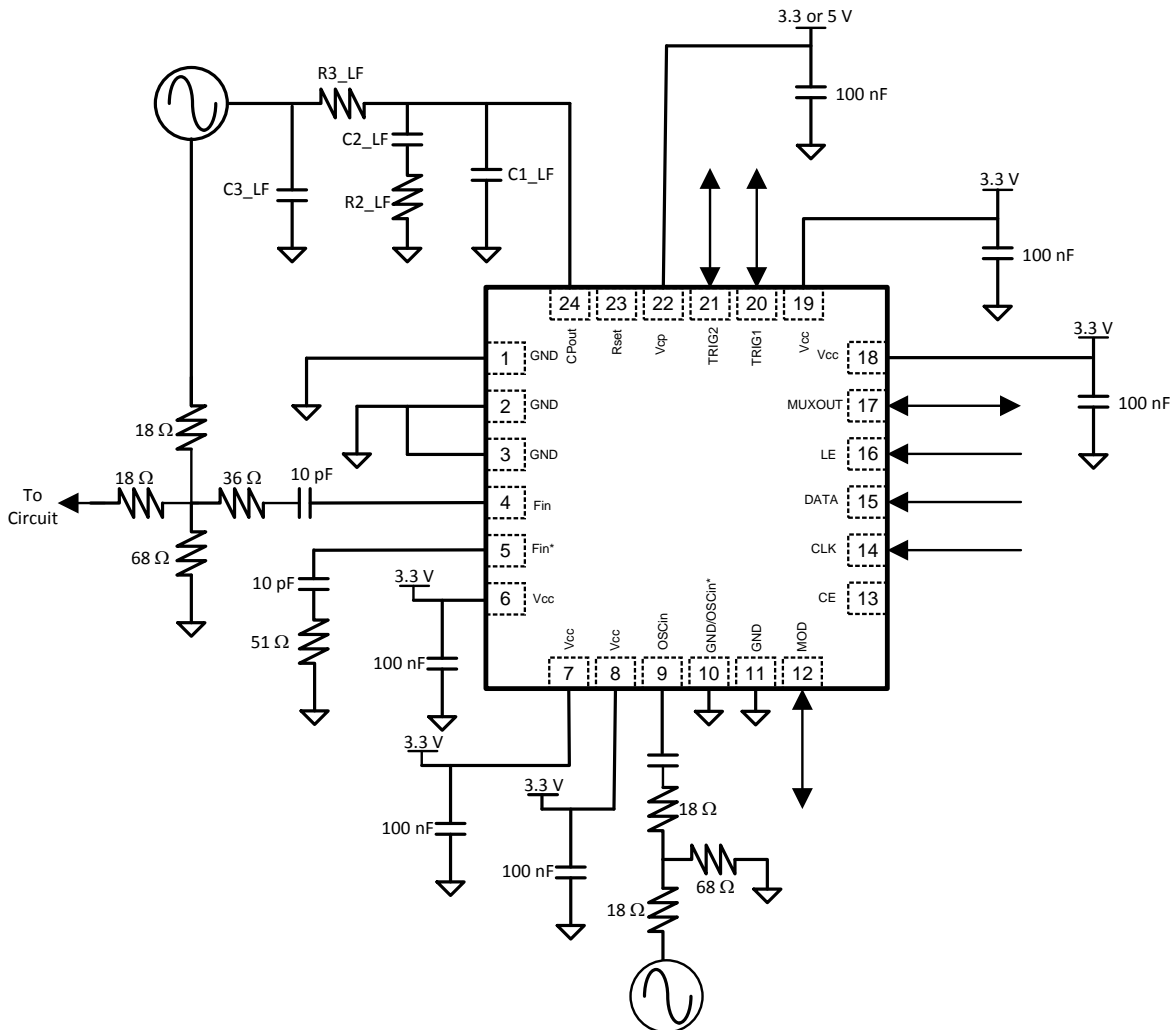
9 Applications and Implementation

9.1 Application Information

The LMX2492/92-Q1 can be used in a broad class of applications such as generating a single frequency for a high frequency clock, generating a tunable range of frequencies, or generating swept waveforms that can be used in applications such as radar.

9.2 Typical Applications

The following schematic is an example of hat could be used in a typical application.



9.2.1 Design Requirements

For these examples, it will be assumed that there is a 100 MHz input signal and the output frequency is between 9400 and 9800 MHz with various modulated waveforms.

Parameter	Symbol	Value	Comments
Input Frequency	OSCin	100 MHz	
Phase Detector Frequency	Fpd	100 MHz	There are many possibilities, but this choice gives good performance and saves a little current (as shown in the electrical specifications).

Typical Applications (continued)

Parameter	Symbol	Value	Comments
VCO Frequency	Fvco	9400 - 9800 MHz (Simple Chirp)	In the different examples, the VCO frequency is actually changing. However, the same loop filter design can be used for all three.
		9400 - 9800 (Flattened Ramp)	
		9500 - 9625 MHz (Complex Triggered Ramp)	
VCO Gain	Kvco	200 MHz/V	This parameter has nothing to do with the LMX2492/92-Q1, but is rather set by the external VCO choice.

9.2.2 Detailed Design Procedure

The first step is to calculate the reference divider (PLL_R) and feedback divider (PLL_N) values as shown in the table that follows.

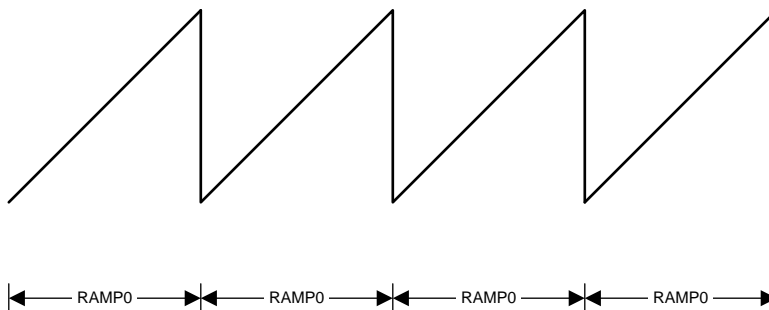
Parameter	Symbol and Calculations	Value	Comments
Average VCO Frequency	$F_{VCO_{Avg}} = (F_{VCO_{Max}} + F_{VCO_{Min}})/2$	9600 MHz	To design a loop filter, one designs for a fixed VCO value, although it is understood that the VCO will tune around. This typical value is usually chosen as the average VCO frequency.
VCO Gain	Kvco	200 MHz/V	This parameter has nothing to do with the LMX2492/92-Q1, but is rather set by the external VCO choice. In this case, it was the RFMD1843 VCO.
PLL Loop Bandwidth	BW	380 kHz	This bandwidth is very wide to allow the VCO frequency to be modulated.
Charge Pump Gain	CPG	3.1 mA	Using the larger gain allows a wider loop bandwidth and gives good phase performance.
R Divider	$PLL_R = OSC_{in} / F_{pd}$	1	This value is calculated from previous values.
N Divider	$PLL_N = F_{vco} / F_{pd}$	96	This value is calculated from previous values.
Loop Filter Components	C1_LF	68 pF	These were calculated by TI design tools.
	C2_LF	3.9 nF	
	C3_LF	150 pF	
	R2_LF	390 ohm	
	R3_LF	390 ohm	

Once a loop filter bandwidth is chosen, the external loop filter components of C1_LF, C2_LF, C3_LF, R2_LF, and R3_LF can be calculated with a tool such as the Clock Architect tool available at www.ti.com. It is also highly recommended to look at the EVM instructions. The CodeLoader software is an excellent starting point and example to see how to program this device.

9.2.3 Application Performance Plot - Sawtooth Waveform Example

Using the above design, it can be programmed to generate a sawtooth waveform with the following parameters.

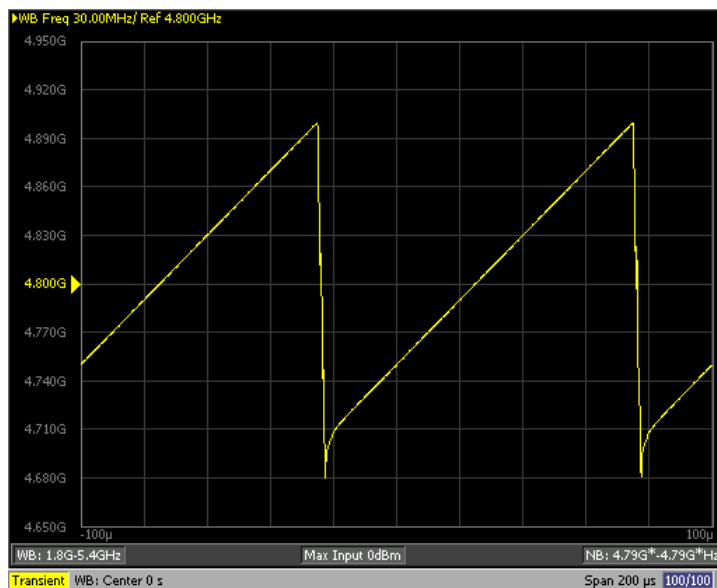
Parameter	Symbol	Value
Ramp Duration	ΔT	100 μ S
VCO Frequency	F _{vco}	9400 - 9800 MHz
Range	ΔF	9400 - 9800 MHz = 400 MHz Change



Because we want the ramp length to be 100 μ s, this works out to 10,000 phase detector cycles which means that RAMP0_LEN=10000. To change 400 MHz, we know that each one of the 10000 steps is 40 kHz. Given the fractional denominator is $2^{24} = 16777216$ and the phase detector frequency is 100 MHz, this implies that the fractional numerator at the end of the ramp will be 6711. However, since this 6711 number is not exact (closer to 6718.8864), the ramp will creep if we do not reset it. Therefore, we set reset the ramp. After the ramp finishes, we want to start with the same ramp, so RAMP0_NEXT is RAMP0. The results of this analysis are in the table below:

RAMP	RAMP0_LEN	RAMP0_INC	RAMP0_NEXT	RAMP0_RST
RAMP0	$\Delta T \times F_{pd} = 100 \mu s / 100 \text{ MHz} = 10000$	$(\Delta F / F_{pd}) / RAMP0_LEN \times 2^{24} = (400/100)/10000 \times 16777216 = 6711$	0	1

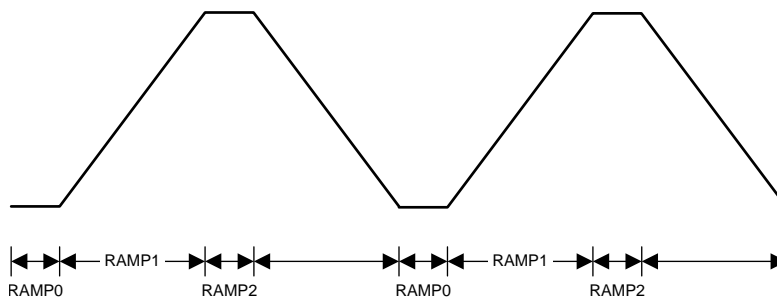
The actual measured waveform for this is shown in the following figure. Note that the frequency that was actually measured was from the divide by two output of the VCO and therefore the measured frequency was half of the actual frequency presented to the PLL. This ramping waveform does show some undershoot as the frequency rapidly returns from 9800 MHz (4900 MHz on the plot) to 9400 MHz (4700 MHz on the plot). This undershoot can be mitigated by adding additional ramps.



9.2.4 Application Performance Plot - Flat Top Triangle Waveform

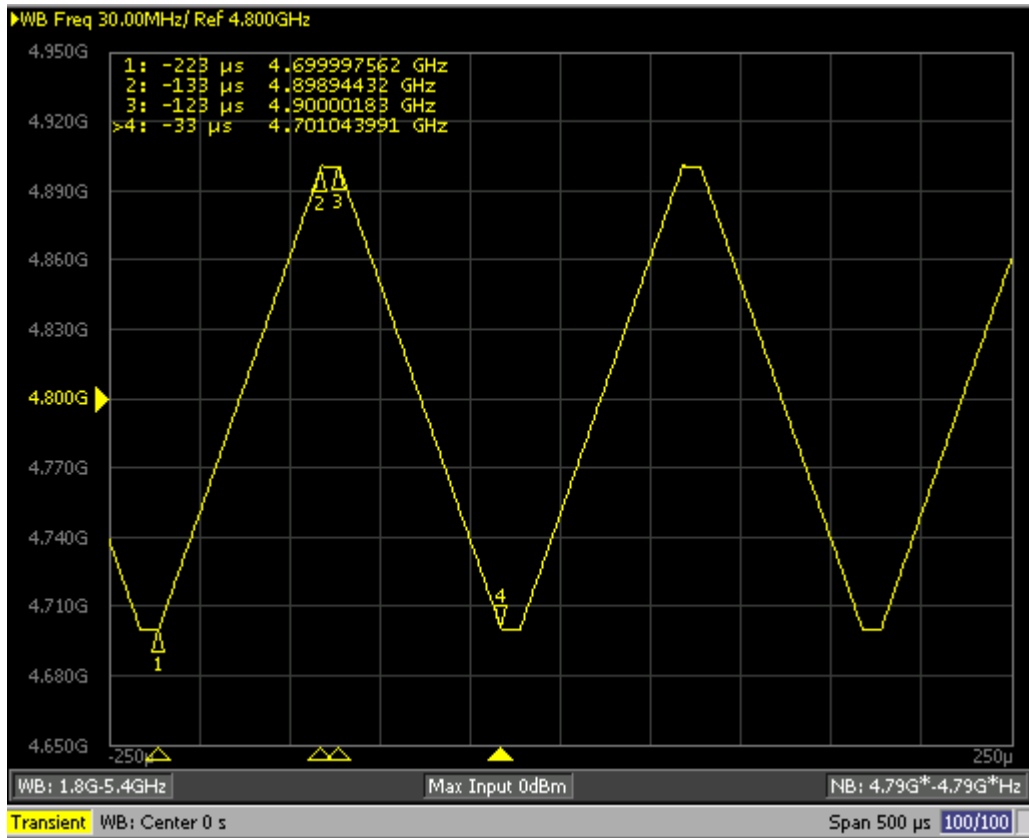
Now consider pattern as shown below. The ramp is sometimes used because it can better account for Doppler Shift. The purpose for making the top and bottom portions flat is to help reduce the impact of the PLL overshooting and undershooting in order to make the sloped ramped portions more linear.

Parameter	Symbol	Value
Ramp Duration	$\Delta T0$	10 μ S
	$\Delta T1$	90 μ S
	$\Delta T2$	10 μ S
	$\Delta T3$	90 μ S
Range	$\Delta F0$	0
	$\Delta F1$	400 MHz
	$\Delta F2$	0
	$\Delta F3$	-400 MHz



RAMP	RAMPx_LEN	RAMPx_INC	RAMPx_NEXT	RAMPx_RST
RAMP0	10 μ s / 100 MHz =1000	0	1	1
RAMP1	90 μ s / 100 MHz =9000	$(\Delta F / F_{pd}) / RAMP1_LEN \times 2^{24}$ $= (400/100)/9000 \times 16777216 = 7457$	2	0
RAMP2	10 μ s / 100 MHz =1000	0	3	0
RAMP3	90 μ s / 100 MHz =9000	$(\Delta F / F_{pd}) / RAMP1_LEN \times 2^{24}$ $= (-400/100)/9000 \times 16777216 = -7457$ Program in 2's complement of -7457 $= 2^{30} - 7457 = 1073734367$	0	0

The actual measured waveform for this is shown in the following figure. Note that the frequency that was actually measured was from the divide by two output of the VCO and therefore the measured frequency was half of the actual frequency presented to the PLL. The flattened top and bottom of this triangle wave help mitigate the overshoot and undershoot in the frequency.



The actual measured waveform for this is shown in the following figure. Note that the frequency that was actually measured was from the divide by two output of the VCO and therefore the measured frequency was half of the actual frequency presented to the PLL. The flattened top and bottom of this triangle wave help mitigate the overshoot and undershoot in the frequency.

9.2.5 Applications Performance Plot -- Complex Triggered Ramp

In this example, the modulation is not started until a trigger pulse from the MOD terminal goes high. Assume a phase detector frequency of 100 MHz and we RAMP1 to be 60 us and ramps 2,3,and 4 to be 12 us each. We set the next trigger for RAMP0 to be trigger A and define trigger A to be the MOD terminal. Then we configure as follows:

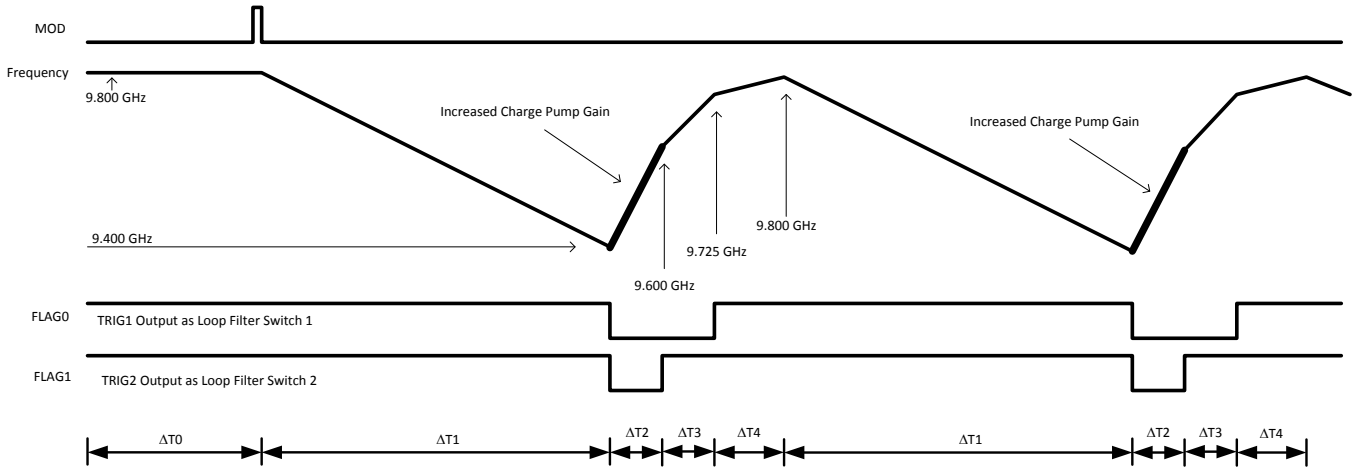


Figure 5. Complex Triggered Ramp Example

RAMP	RAMPx_LEN	RAMPx_INC	RAMPx_FL	RAMPx_NEXT	RAMPx_FLAG	RAMPx_NEXT_TRIG	RAMPx_RST
RAMP0	1	0	0	1	FLAG0 and FLAG1	TRIG A	1
RAMP1	6000	1073730639	0	2	FLAG0 and FLAG1	TOC Timeout	1
RAMP2	1200	27963	1	3	Disabled	TOC Timeout	0
RAMP3	1200	17476	0	4	FLAG1	TOC Timeout	0
RAMP4	1200	10486	0	1	FLAG0 and FLAG1	TOC Timeout	0

The actual measured waveform for this is shown in the following figure. Note that the frequency that was actually measured was from the divide by two output of the VCO and therefore the measured frequency was half of the actual frequency presented to the PLL. The flattened top and bottom of this triangle wave help mitigate the overshoot and undershoot in the frequency.

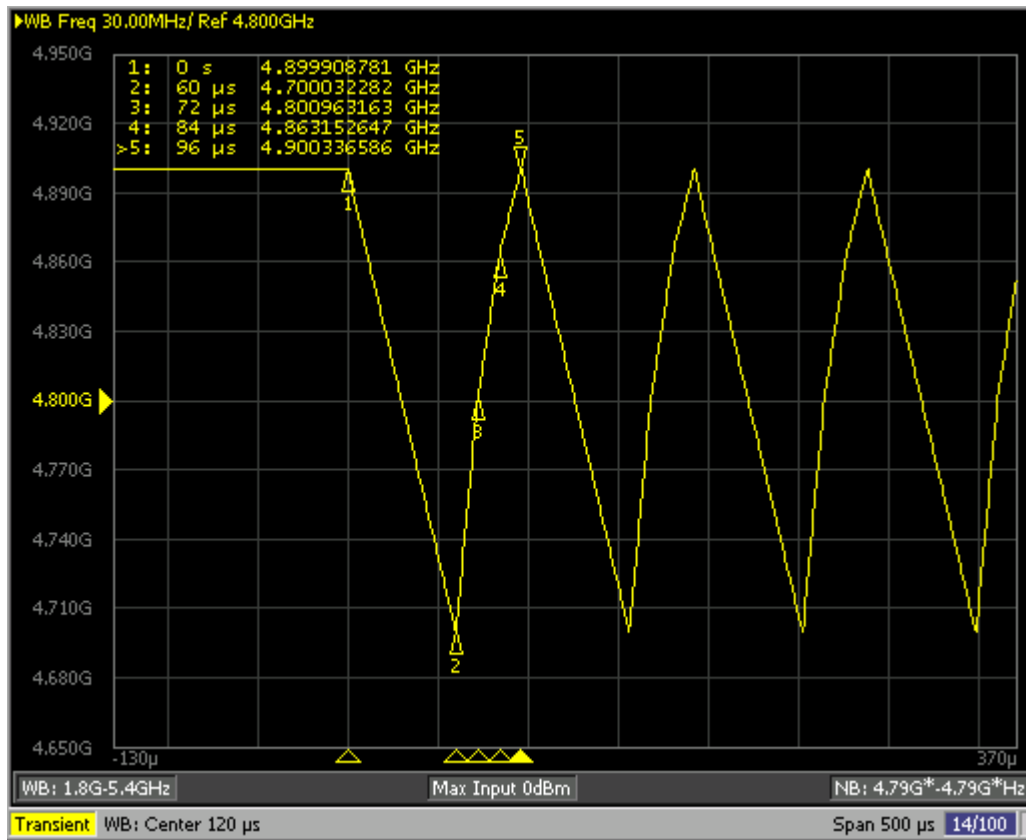


Figure 6. Actual Measurement for Complex Triggered Ramp

10 Power Supply Recommendations

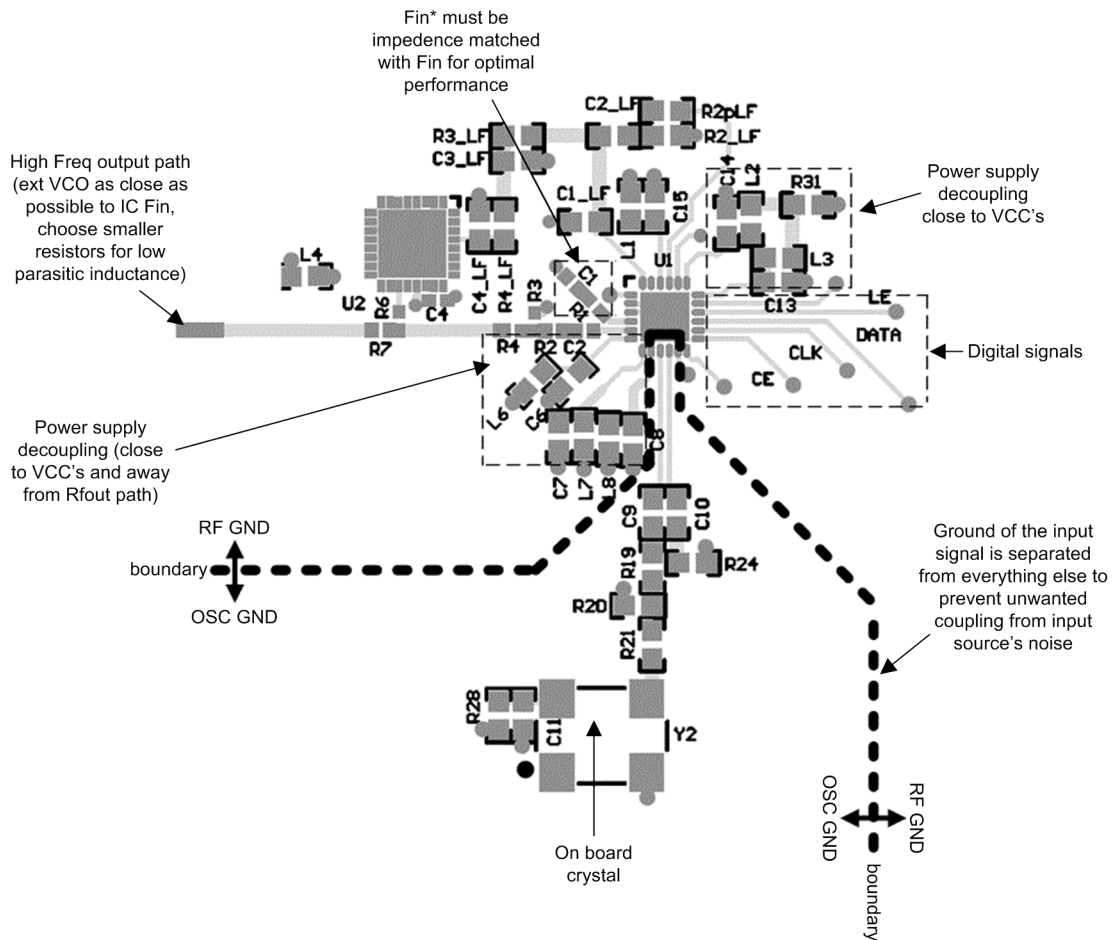
For power supplies, it is recommended to place 100 nF close to each of the power supply pins. If fractional spurs are a large concern, using a ferrite bead to each of these power supply pins can reduce spurs to a small degree.

11 Layout

11.1 Layout Guidelines

For layout examples, the EVM instructions are the most comprehensive document. In general, the layout guidelines are similar to most other PLL devices. For the high frequency Fin pin, it is recommended to use 0402 components and match the trace width to these pad sizes. Also the same needs to be done on the Fin* pin. If layout is easier to route the signal to Fin* instead of Fin, then this is acceptable as well.

11.2 Layout Example



12 Device and Documentation Support

12.1 Device Support

12.1.1 Development Support

Texas Instruments has several software tools to aid in the development process including CodeLoder for programming, Clock Design Tool for Loop filter design and phase noise/spur simulation, and the Clock Architect. All these tools are available at www.ti.com.

12.2 Documentation Support

12.2.1 Related Documentation

For the avid reader, the following resources are available at www.ti.com.

Application Note 1879 -- Fractional N Frequency Synthesis

PLL Performance, Simulation, and Design -- by Dean Banerjee

12.3 Related Links

The table below lists quick access links. Categories include technical documents, support and community resources, tools and software, and quick access to sample or buy.

Table 10. Related Links

PARTS	PRODUCT FOLDER	SAMPLE and BUY	TECHNICAL DOCUMENTS	TOOLS and SOFTWARE	SUPPORT and COMMUNITY
LMX2492	Click here	Click here	Click here	Click here	Click here
LMX2492-Q1	Click here	Click here	Click here	Click here	Click here

12.4 Trademarks

All trademarks are the property of their respective owners.

12.5 Electrostatic Discharge Caution



These devices have limited built-in ESD protection. The leads should be shorted together or the device placed in conductive foam during storage or handling to prevent electrostatic damage to the MOS gates.

12.6 Glossary

[SLYZ022](#) — *TI Glossary*.

This glossary lists and explains terms, acronyms and definitions.

13 Mechanical, Packaging, and Orderable Information

The following pages include mechanical packaging and orderable information. This information is the most current data available for the designated devices. This data is subject to change without notice and revision of this document. For browser-based versions of this data sheet, refer to the left-hand navigation.

PACKAGING INFORMATION

Orderable Device	Status (1)	Package Type	Package Drawing	Pins	Package Qty	Eco Plan (2)	Lead/Ball Finish (6)	MSL Peak Temp (3)	Op Temp (°C)	Device Marking (4/5)	Samples
LMX2492QRTWRQ1	ACTIVE	WQFN	RTW	24	1000	Green (RoHS & no Sb/Br)	CU SN	Level-3-260C-168 HR	-40 to 125	X2492Q	Samples
LMX2492QRTWTQ1	ACTIVE	WQFN	RTW	24	250	Green (RoHS & no Sb/Br)	CU SN	Level-3-260C-168 HR	-40 to 125	X2492Q	Samples
LMX2492RTWR	ACTIVE	WQFN	RTW	24	1000	Green (RoHS & no Sb/Br)	CU SN	Level-3-260C-168 HR	-40 to 85	X2492	Samples
LMX2492RTWT	ACTIVE	WQFN	RTW	24	250	Green (RoHS & no Sb/Br)	CU SN	Level-3-260C-168 HR	-40 to 85	X2492	Samples

(1) The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

OBSELETE: TI has discontinued the production of the device.

(2) Eco Plan - The planned eco-friendly classification: Pb-Free (RoHS), Pb-Free (RoHS Exempt), or Green (RoHS & no Sb/Br) - please check <http://www.ti.com/productcontent> for the latest availability information and additional product content details.

TBD: The Pb-Free/Green conversion plan has not been defined.

Pb-Free (RoHS): TI's terms "Lead-Free" or "Pb-Free" mean semiconductor products that are compatible with the current RoHS requirements for all 6 substances, including the requirement that lead not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, TI Pb-Free products are suitable for use in specified lead-free processes.

Pb-Free (RoHS Exempt): This component has a RoHS exemption for either 1) lead-based flip-chip solder bumps used between the die and package, or 2) lead-based die adhesive used between the die and leadframe. The component is otherwise considered Pb-Free (RoHS compatible) as defined above.

Green (RoHS & no Sb/Br): TI defines "Green" to mean Pb-Free (RoHS compatible), and free of Bromine (Br) and Antimony (Sb) based flame retardants (Br or Sb do not exceed 0.1% by weight in homogeneous material)

(3) MSL, Peak Temp. - The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

(4) There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.

(5) Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.

(6) Lead/Ball Finish - Orderable Devices may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead/Ball Finish values may wrap to two lines if the finish value exceeds the maximum column width.

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OTHER QUALIFIED VERSIONS OF LMX2492, LMX2492-Q1 :

- Catalog: [LMX2492](#)
- Automotive: [LMX2492-Q1](#)

NOTE: Qualified Version Definitions:

- Catalog - TI's standard catalog product
- Automotive - Q100 devices qualified for high-reliability automotive applications targeting zero defects

TAPE AND REEL INFORMATION



QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE



*All dimensions are nominal

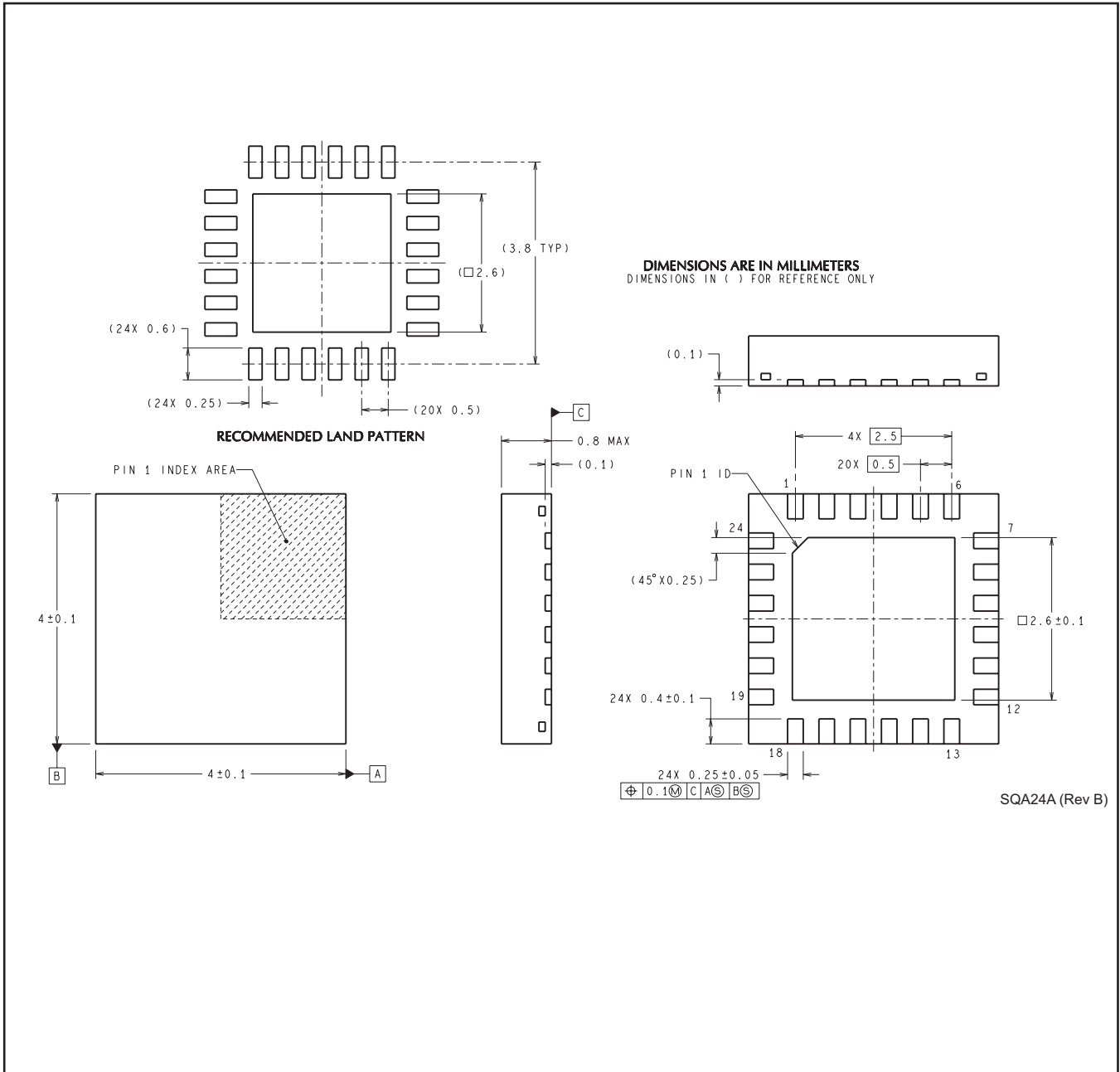
Device	Package Type	Package Drawing	Pins	SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
LMX2492QRTWRQ1	WQFN	RTW	24	1000	178.0	12.4	4.3	4.3	1.3	8.0	12.0	Q1
LMX2492QRTWTQ1	WQFN	RTW	24	250	178.0	12.4	4.3	4.3	1.3	8.0	12.0	Q1
LMX2492RTWR	WQFN	RTW	24	1000	178.0	12.4	4.3	4.3	1.3	8.0	12.0	Q1
LMX2492RTWT	WQFN	RTW	24	250	178.0	12.4	4.3	4.3	1.3	8.0	12.0	Q1

TAPE AND REEL BOX DIMENSIONS


*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
LMX2492QRTWRQ1	WQFN	RTW	24	1000	213.0	191.0	55.0
LMX2492QRTWTQ1	WQFN	RTW	24	250	213.0	191.0	55.0
LMX2492RTWR	WQFN	RTW	24	1000	213.0	191.0	55.0
LMX2492RTWT	WQFN	RTW	24	250	213.0	191.0	55.0

RTW0024A



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